Dual double-pole double-throw analog switch

Rev. 3.2 — 21 June 2024

Product data sheet

1 General description

The NX3DV3899 is a dual double-pole double-throw analog data-switch suitable for use as an analog or digital multiplexer/demultiplexer. It consists of four switches, each with two independent input/outputs (nY0 and nY1) and a common input/output (nZ). The two digital inputs (1S and 2S) are used to select the switch position. Schmitt trigger action at the select input (nS) makes the circuit tolerant to slower input rise and fall times across the entire V_{CC} range from 1.4 V to 4.3 V.

A low input voltage threshold allows pin nS to be driven by lower level logic signals without a significant increase in supply current I_{CC} . This makes it possible for the NX3DV3899 to switch 4.3 V signals with a 1.8 V digital controller, eliminating the need for logic level translation. The NX3DV3899 allows signals with amplitude up to V_{CC} to be transmitted from nZ to nY0 or nY1; or from nY0 or nY1 to nZ.

2 Features and benefits

- Wide supply voltage range from 1.4 V to 4.3 V
- Very low ON resistance (peak):
- 7.2 Ω (typical) at V_{CC} = 1.4 V
- 5.4 Ω (typical) at V_{CC} = 1.65 V
- 2.9 Ω (typical) at V_{CC} = 2.5 V
- 2.4 Ω (typical) at V_{CC} = 3.0 V
- 2.3 Ω (typical) at V_{CC} = 3.6 V
- 2.2 Ω (typical) at V_{CC} = 4.3 V
- Break-before-make switching
- High noise immunity
- ESD protection:
 - HBM JESD22-A114F Class 2A exceeds 2000 V (all pins)
 - HBM JESD22-A114F Class 3A exceeds 5000 V (I/O pins to GND)
 - MM JESD22-A115-A exceeds 200 V
 - CDM AEC-Q100-011 revision B exceeds 1000 V
- CMOS low-power consumption
- Latch-up performance exceeds 100 mA per JESD 78B Class II Level A
- 1.8 V control logic at V_{CC} = 3.6 V
- Control input accepts voltages above supply voltage
- Very low supply current, even when input is below V_{CC}
- High current handling capability (350 mA continuous current under 3.3 V supply)
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

3 Applications

- Data switch
- Cell phone



• PDA

· Portable media player

Ordering information 4

Table 1. Ordering information

Type number	Topside	Package								
Type number	marking	Name	Description	Version						
NX3DV3899HR	x99		plastic thermal enhanced extremely thin quad flat package; no leads; 16 terminals; body 3 mm x 3 mm x 0.5 mm	SOT1039-2						
NX3DV3899GU	x9	XQFN16	plastic, extremely thin quad flat package; no leads; 16 terminals; body 1.80 x 2.60 x 0.50 mm	SOT1161-1						

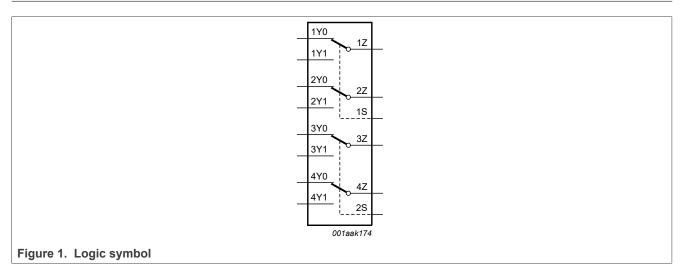
Table 2. Ordering options

Type number	Orderable part number	Package		Minimum order quantity	Temperature range
NX3DV3899HR	NX3DV3899HR,115	HXQFN16(U)	REEL 7" Q1 NDP ^[1]	1500	-40°C to +125°C
	NX3DV3899HRZ	HXQFN16(U)	REEL 7" Q1 NDP SSB ^[2]	1500	-40°C to +125°C
NX3DV3899GU	NX3DV3899GU,115	XQFN16	REEL 7" Q1 NDP	4000	-40°C to +125°C

[1]

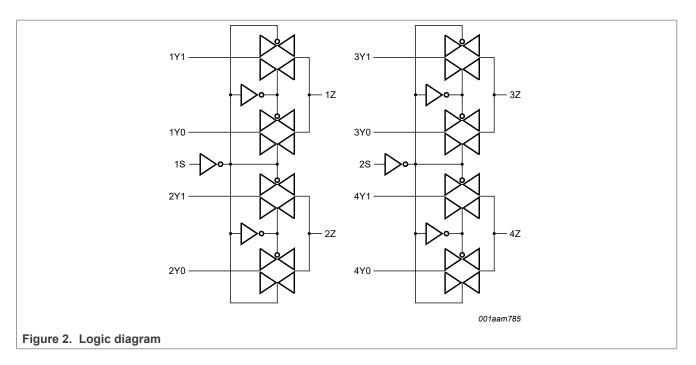
Will go EOL - migrate to new leadframe NX3DV3899HRZ orderable part number. This packing method uses a Static Shielding Bag (SSB) solution. Material is to be kept in the sealed bag between uses. [2]

Functional diagram 5



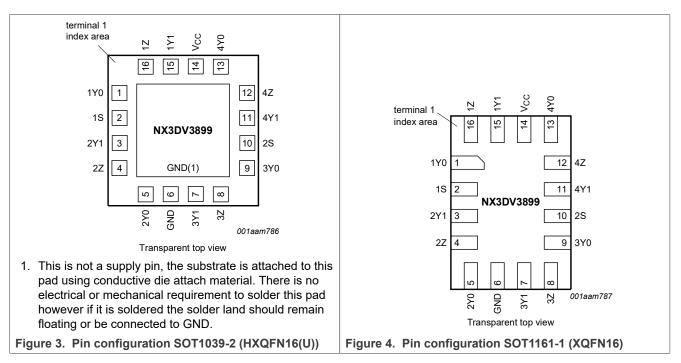
Product data sheet

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6 Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1Y0, 2Y0, 3Y0, 4Y0	1, 5, 9, 13	independent input or output
1S, 2S	2, 10	select input
1Y1, 2Y1, 3Y1, 4Y1	15, 3, 7, 11	independent input or output
1Z, 2Z, 3Z, 4Z	16, 4, 8, 12	common output or input
GND	6	ground (0 V)
V _{CC}	14	supply voltage

7 Functional description

Table 4. Function table^[1]

Input nS	Channel on
L	nY0
Н	nY1

H = HIGH voltage level; L = LOW voltage level. [1]

Limiting values 8

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+4.6	V
VI	input voltage	select input nS		-0.5	+4.6	V
V _{SW}	switch voltage		[2]	-0.5	V _{CC} + 0.5	V
I _{IK}	input clamping current	V ₁ < -0.5 V		-50	-	mA
I _{SK}	switch clamping current	$V_{\rm I} < -0.5 \ V \ {\rm or} \ V_{\rm I} > V_{\rm CC} + 0.5 \ V$		-	±50	mA
I _{SW}	switch current	V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; source or sink current		-	±350	mA
		V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; pulsed at 1 ms duration, < 10 % duty cycle; peak current		-	±500	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C				
		HXQFN16(U)	[3]	-	250	mW
		XQFN16	[4]	-	250	mW

The minimum input voltage rating may be exceeded if the input current rating is observed. [1]

[2] [3] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed but may not exceed 4.6 V.

For HXQFN16(U) package: above 135 °C the value of Ptot derates linearly with 16.9 mW/K.

[4] For XQFN16 package: above 133 °C the value of Ptot derates linearly with 14.5 mW/K.

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9 Recommended operating conditions

	Devenuetor		Conditions				
Table 6. Recommended operating conditions							

Symbol	Parameter	Conditions		Min	Мах	Unit
V _{CC}	supply voltage			1.4	4.3	V
VI	input voltage	select input nS		0	4.3	V
V _{SW}	switch voltage		[1]	0	V _{CC}	V
T _{amb}	ambient temperature			-40	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.4 V to 4.3 V	[2]	-	200	ns/V

[1] To avoid sinking GND current from terminal nZ when switch current flows in terminal nYn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal nZ, no GND current will flow from terminal nYn. In this case, there is no limit for the voltage drop across the switch.

[2] Applies to control signal levels.

10 Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	Ta	_{mb} = 25	°C	T _{amb} =	Unit		
			Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)	
V _{IH}	HIGH-level	V _{CC} = 1.4 V to 1.6 V	0.9	-	-	0.9	-	-	V
	input voltage	V _{CC} = 1.65 V to 1.95 V	0.9	-	-	0.9	-	-	V
		V _{CC} = 2.3 V to 2.7 V	1.1	-	-	1.1	-	-	V
		V _{CC} = 2.7 V to 3.6 V	1.3	-	-	1.3	-	-	V
		V _{CC} = 3.6 V to 4.3 V	1.4	-	-	1.4	-	-	V
V _{IL}	LOW-level	V _{CC} = 1.4 V to 1.6 V	-	-	0.3	-	0.3	0.3	V
	input voltage	V _{CC} = 1.65 V to 1.95 V	-	-	0.4	-	0.4	0.3	V
		V _{CC} = 2.3 V to 2.7 V	-	-	0.4	-	0.4	0.4	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.5	-	0.5	0.5	V
		V _{CC} = 3.6 V to 4.3 V	-	-	0.6	-	0.6	0.6	V
lı	input leakage current	select input nS; V_I = GND to 4.3 V; V_{CC} = 1.4 V to 4.3 V	-	-	-	-	±0.5	±1	μA
I _{S(OFF)}	OFF-state leakage	nY0 and nY1 port; see <u>Figure 5</u>							
	current	V _{CC} = 1.4 V to 4.3 V	-	-	±5	-	±50	±500	nA
I _{S(ON)}	ON-state	nZ port; see <u>Figure 6</u>							
	leakage current	V _{CC} = 1.4 V to 4.3 V	-	-	±5	-	±50	±500	nA
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $V_{SW} =$ GND or V_{CC}							
		V _{CC} = 3.6 V	-	-	100	-	500	5000	nA

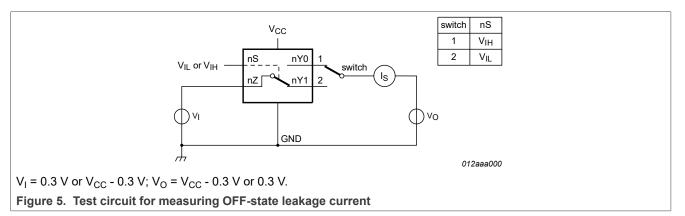
Dual double-pole double-throw analog switch

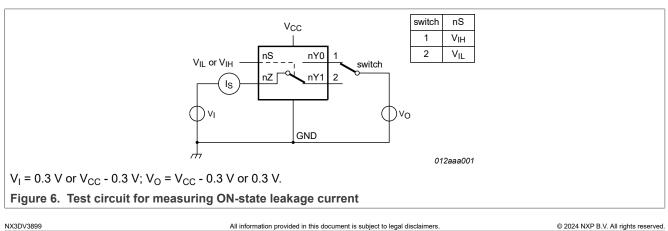
Table 7. Static characteristics...continued

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions		Tai	_{mb} = 25	°C	T _{amb} =	Unit		
				Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)	
		V _{CC} = 4.3 V		-	-	150	-	800	6000	nA
ΔI _{CC}	additional	V _{SW} = GND or V _{CC}								
	supply current	V _I = 2.6 V; V _{CC} = 4.3 V		-	2.0	4.0	-	7	7	μA
		V _I = 2.6 V; V _{CC} = 3.6 V		-	0.35	0.7	-	1	1	μA
		V _I = 1.8 V; V _{CC} = 4.3 V		-	7.0	10.0	-	15	15	μA
		V _I = 1.8 V; V _{CC} = 3.6 V		-	2.5	4.0	-	5	5	μA
		V _I = 1.8 V; V _{CC} = 2.5 V		-	50	200	-	300	500	nA
CI	input capacitance			-	1.0	-	-	-	-	pF
$C_{S(OFF)}$	OFF-state capacitance			-	8	-	-	-	-	pF
C _{S(ON)}	ON-state capacitance			-	30	-	-	-	-	pF

10.1 Test circuits





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10.2 ON resistance

Table 8. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see Figure 8 to Figure 14.

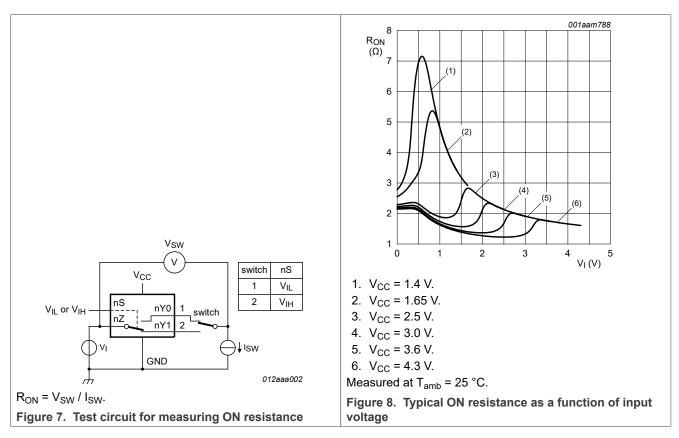
Symbol	Parameter	Conditions	Conditions		• -40 °C to	o +85 °C	T _{amb} = -40 °	Unit	
				Min	Typ ^[1]	Мах	Min	Max	
R _{ON(peak)}	ON resistance (peak)	$V_I = GND$ to V_{CC} ; $I_{SW} = 100$ mA; see <u>Figure 7</u>							
		V _{CC} = 1.4 V		-	7.2	9.3	-	10	Ω
		V _{CC} = 1.65 V		-	5.4	7.3	-	8	Ω
		V _{CC} = 2.5 V		-	2.9	3.9	-	4.5	Ω
		V _{CC} = 3.0 V		-	2.4	3.4	-	4.5	Ω
		V _{CC} = 3.6 V		-	2.3	3.3	-	4.2	Ω
		V _{CC} = 4.3 V		-	2.2	3.3	-	4.2	Ω
ΔR _{ON}	ON resistance mismatch	$V_I = GND$ to V_{CC} ; $I_{SW} = 100$ mA	[2]						
	between channels	V _{CC} = 3.0 V		-	0.8	-	-	-	Ω
		V _{CC} = 4.3 V		-	0.7	-	-	-	Ω
R _{ON(flat)}	ON resistance (flatness)	$V_I = GND$ to V_{CC} ; $I_{SW} = 100$ mA	[3]						
		V _{CC} = 1.4 V		-	4.4	-	-	-	Ω
		V _{CC} = 1.65 V		-	2.8	-	-	-	Ω
		V _{CC} = 2.5 V		-	1.0	-	-	-	Ω
		V _{CC} = 3.0 V		-	0.8	-	-	-	Ω
		V _{CC} = 3.6 V		-	0.9	-	-	-	Ω
		V _{CC} = 4.3 V		-	1.0	-	-	-	Ω

[1]

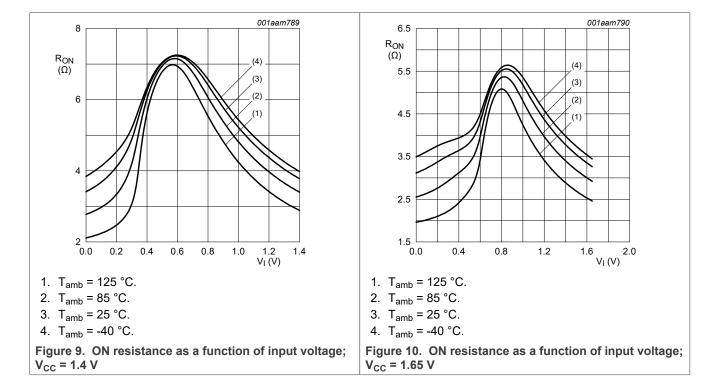
[2] [3]

Typical values are measured at $T_{amb} = 25 \text{ °C}$. Measured at identical V_{CC} , temperature and input voltage. Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical V_{CC} and temperature.

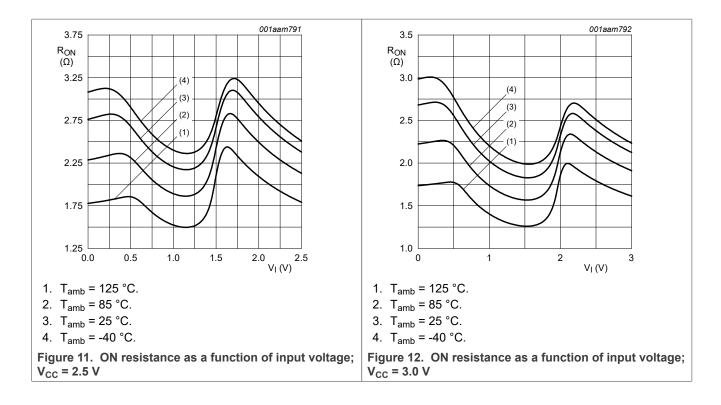
Dual double-pole double-throw analog switch

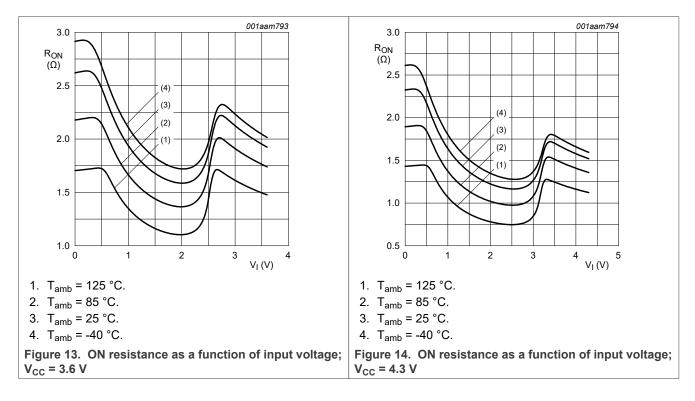


10.3 ON resistance test circuit and graphs



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Dynamic characteristics 11

Table 9. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 17.

Symbol	Parameter	Conditions		٦	۲ _{amb} = 25 °	С	T _{amb} =	Unit		
				Min	Typ ^[1]	Max	Min	Max (85 °C)	Max (125 °C)	
t _{en}	enable time	nS to nZ or nYn; see Figure 15								
		V _{CC} = 1.4 V to 1.6 V		-	41	90	-	120	120	ns
		V _{CC} = 1.65 V to 1.95 V		-	30	70	-	80	90	ns
		V_{CC} = 2.3 V to 2.7 V		-	20	45	-	50	55	ns
		V _{CC} = 2.7 V to 3.6 V		-	19	40	-	45	50	ns
		V _{CC} = 3.6 V to 4.3 V		-	19	40	-	45	50	ns
t _{dis}	disable time	nS to nZ or nYn; see Figure 15								
		V _{CC} = 1.4 V to 1.6 V		-	24	70	-	80	90	ns
		V _{CC} = 1.65 V to 1.95 V		-	15	55	-	60	65	ns
		V_{CC} = 2.3 V to 2.7 V		-	9	25	-	30	35	ns
		V _{CC} = 2.7 V to 3.6 V		-	8	20	-	25	30	ns
		V_{CC} = 3.6 V to 4.3 V		-	8	20	-	25	30	ns
t _{b-m}	break-before-	see <u>Figure 16</u>	[2]							
	make time	V _{CC} = 1.4 V to 1.6 V		-	20	-	9	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		-	17	-	7	-	-	ns
		V_{CC} = 2.3 V to 2.7 V		-	13	-	4	-	-	ns
		V _{CC} = 2.7 V to 3.6 V		-	11	-	3	-	-	ns
		V_{CC} = 3.6 V to 4.3 V		-	11	-	2	-	-	ns

Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.5 V, 1.8 V, 2.5 V, 3.3 V and 4.3 V respectively. Break-before-make guaranteed by design. [1]

[2]

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11.1 Waveform and test circuits

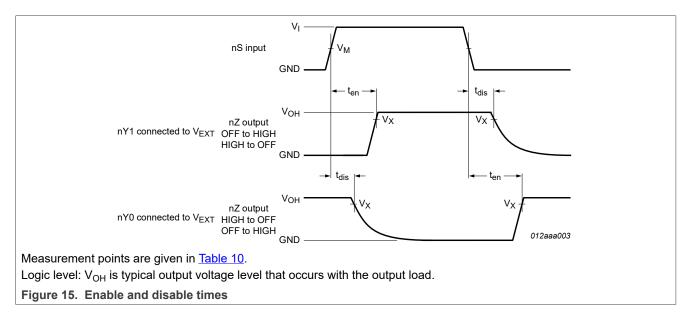
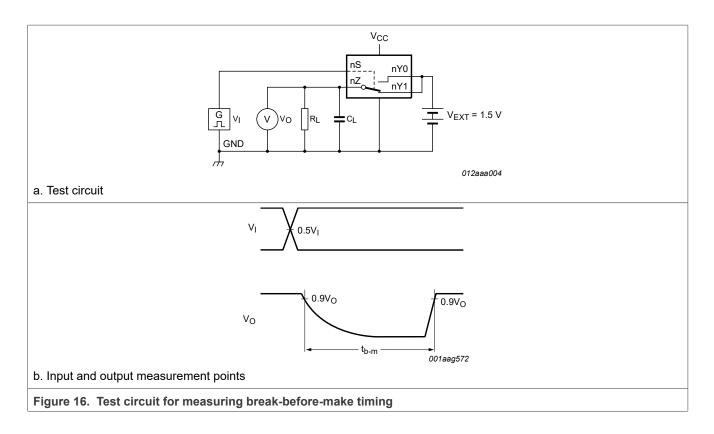


Table 10. Measurement points

Supply voltage	Input	Output
V _{cc}	V _M	V _X
1.4 V to 4.3 V	0.5V _{CC}	0.9V _{OH}

Dual double-pole double-throw analog switch



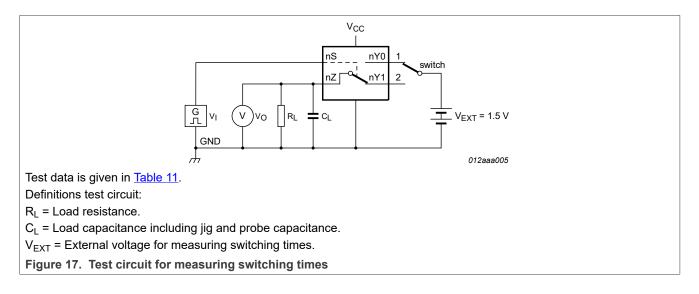


Table 11. Test data

Supply voltage	Input		Load	
Vcc	VI	t _r , t _f	CL	RL
1.4 V to 4.3 V	V _{CC}	≤ 2.5 ns	35 pF	50 Ω

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11.2 Additional dynamic characteristics

Table 12. Additional dynamic characteristics

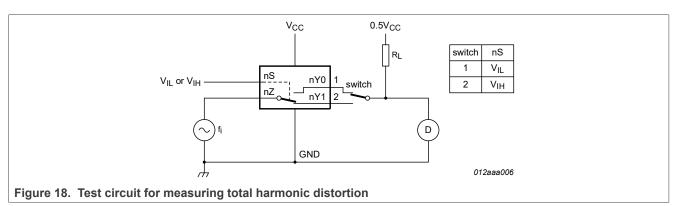
At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $V_l = GND$ or V_{CC} (unless otherwise specified); $t_r = t_f \le 2.5$ ns; $T_{amb} = 25$ °C.

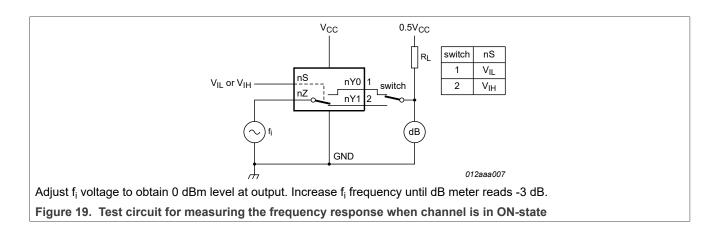
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
THD total harmonic distortion		$f_i = 20$ Hz to 20 kHz; $R_L = 600 \Omega$; see Figure 18	[1]				
	distortion	V _{CC} = 1.4 V; V _I = 1 V (p-p)		-	0.05	-	%
		V _{CC} = 1.65 V; V _I = 1.2 V (p-p)		-	0.02	-	%
		V _{CC} = 2.3 V; V _I = 1.5 V (p-p)		-	0.01	-	%
		V _{CC} = 2.7 V; V _I = 2 V (p-p)		-	0.01	-	%
		V _{CC} = 3.6 V; V _I = 2 V (p-p)		-	0.01	-	%
		V _{CC} = 4.3 V; V _I = 2 V (p-p)		-	0.01	-	%
f _(-3dB)	-3 dB frequency	R_L = 50 Ω; see <u>Figure 19</u>	[1]				
	response	V _{CC} = 1.4 V to 4.3 V		-	200	-	MHz
α _{iso}	isolation (OFF-state)	$f_i = 1 \text{ MHz}; R_L = 50 \Omega; \text{ see } Figure 20$	[1]				
	V _{CC} = 1.4 V to 4.3 V		-	-70	-	dB	
V _{ct} crosstalk voltage	between digital inputs and switch; $f_i = 1 \text{ MHz}$; $C_L = 50 \text{ pF}$; $R_L = 50 \Omega$; see Figure 21						
		V _{CC} = 1.4 V to 3.6 V		-	210	-	V
		V _{CC} = 3.6 V to 4.3 V		-	300	-	V
Xtalk	crosstalk	between switches; $f_i = 1 \text{ MHz}$; $R_L = 50 \Omega$; see Figure 22	[1]				
		V _{CC} = 1.4 V to 4.3 V		-	-90	-	dB
Q _{inj} charge injection	$ f_i = 1 \text{ MHz}; \text{C}_L = 0.1 \text{ nF}; \text{R}_L = 1 \text{M}\Omega; \text{V}_{gen} = 0 \text{V}; \text{R}_{gen} \\ = 0 \Omega; \text{ see } \underline{\text{Figure 23}} $						
		V _{CC} = 1.4 V		-	0.5	-	рС
		V _{CC} = 1.65 V		-	0.7	-	рС
		V _{CC} = 2.5 V		-	1.6	-	рС
		V _{CC} = 3.0 V		-	2.1	-	рС
		V _{CC} = 3.6 V		-	2.9	-	рС
		V _{CC} = 4.3 V		-	4.0	-	рС

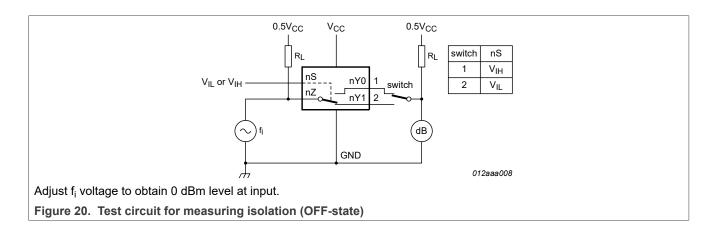
[1] f_i is biased at 0.5V_{CC}.

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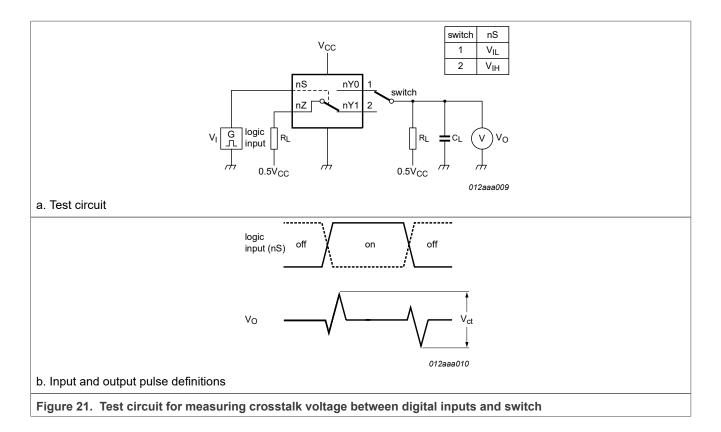
11.3 Test circuits

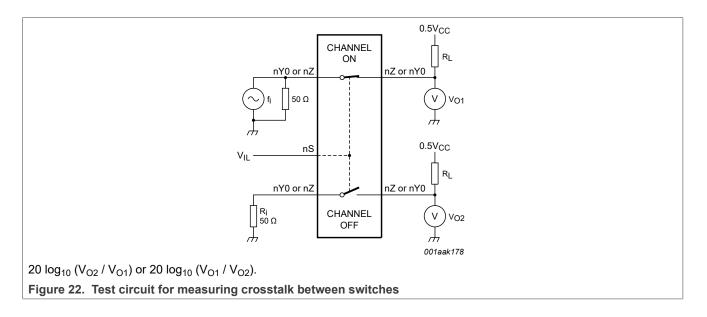




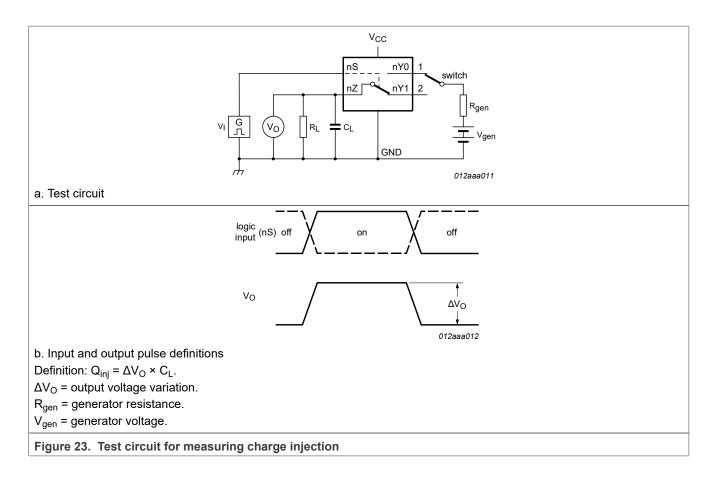


Dual double-pole double-throw analog switch



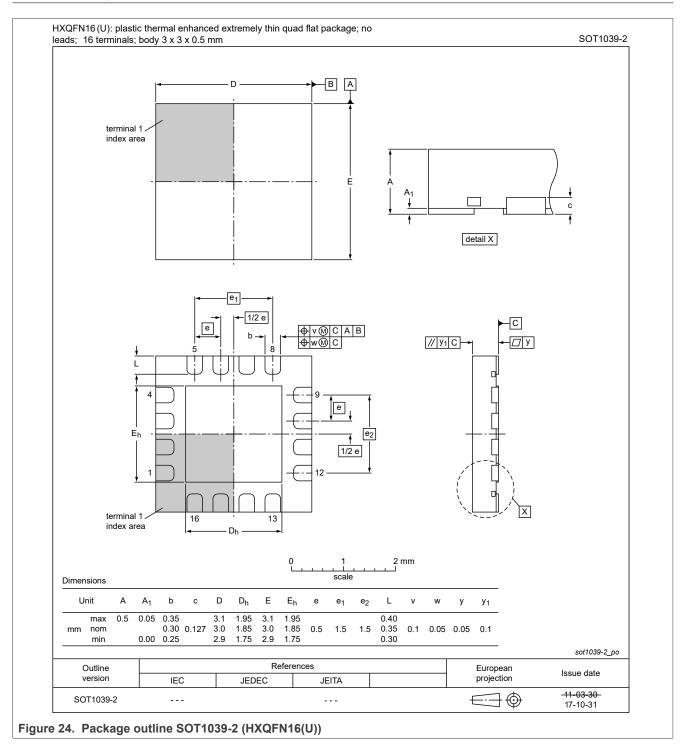


Dual double-pole double-throw analog switch



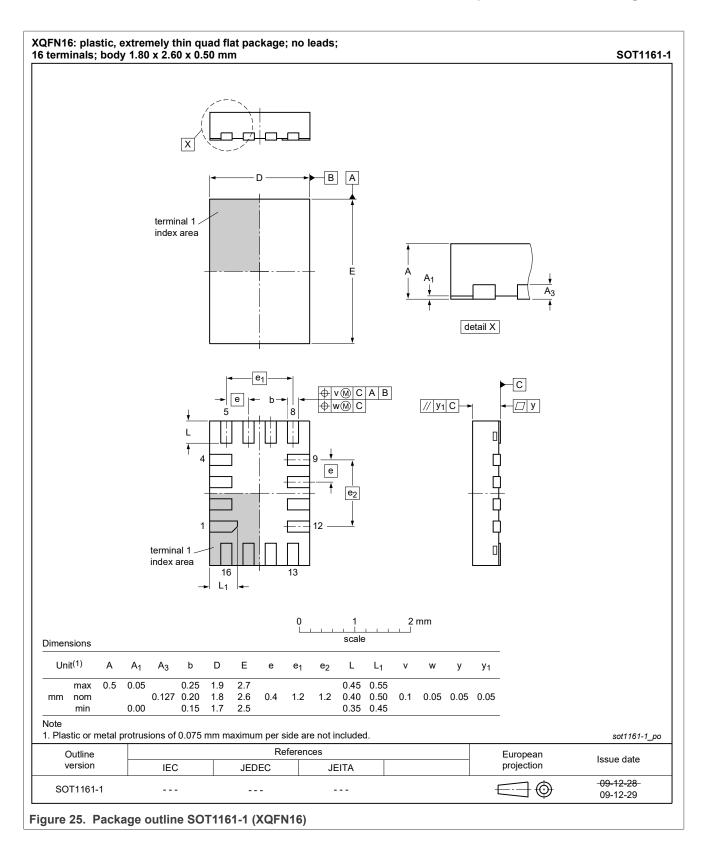
Dual double-pole double-throw analog switch

12 Package outline



Product data sheet

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NX3DV3899 Product data sheet

13 Abbreviations

Table 13. Abbreviations			
Acronym	Description		
CDM	Charged Device Model		
CMOS	Complementary Metal-Oxide Semiconductor		
ESD	ElectroStatic Discharge		
НВМ	Human Body Model		
ММ	Machine Model		
PDA	Personal Digital Assistant		

14 Revision history

Table 14. Revision histor	У	
Document ID	Release date	Description
NX3DV3899 v.3.2	21 June 2024	Updated per CIN 202405025I: • Corrected package outline from SOT1039-1 to SOT1039-2.
NX3DV3899 v.3.1	25 June 2021	Updated Section 4.
NX3DV3899 v.3	9 November 2011	Product data sheet; v.3
NX3DV3899 v.2	23 November 2010	Product data sheet; v.2
NX3DV3899 v.1	21 October 2010	Product data sheet; v.1

Legal information

Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <u>https://www.nxp.com</u>.

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